

WEBINARS

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Quantum Efficiency Measurements: Fundamentals for Solar Cell Research, Part 2

Wednesday, February 21, 2024 1:00 PM - 2:00 PM EST

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Presented by



In part two of this series, representatives from MKS Newport present an in-depth discussion on equipment and test configurations used for cutting-edge cell development such as perovskites and multi-junction cells. These configuration topics include device interfacing, light generation techniques, and signal detection. They discuss specific requirements that are needed to take these measurements as well as the key challenges researchers run into during experimentation. In addition to quantum efficiency measurements, they also review I-V curve generation and analysis for solar module level parameter testing. Join MKS Newport experts to learn and dig into the world of solar cell design measurements and how to set up a lab for success. Presented by MKS Newport.



Upcoming Webinars

- Dual-Comb Ranging for Industrial Applications, 2/13/2024 10:00:00 AM EST
- From Theory to Practice: Coherent Beam Combining's Impact on Laser Technology, 2/15/2024 10:00:00 AM EST
- Laser & Photonics: An Integral Part of Industrial Innovation, 2/27/2024 10:00:00 AM EST

Archived Webinars

- An End-to-End Approach to the Challenges in PIC Packaging
- Automation Technologies to Scale PIC Testing from Lab to Fab
- Photonics Goes Mainstream: Channeling Semiconductors' Challenges

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